



# AMICSA & DSP 2016

## Wednesday, 15 June 2016

### Radiation tests of analogue and mixed-signal ICs (10:00 - 10:40)

-Conveners: Fredrik Stuesson

time	[id] title	presenter
10:00	[13] The pros and cons of in situ testing - going beyond the test standards	Dr RICHARD, Sharp
10:20	[5] Total Ionizing Dose Testing of Solid State Power Amplifiers	Prof. DEMIRKOZ, Melahat Bilge